



Faculty of Engineering and Architecture

Building a better VHDL testing environment

Joren Guillaume

Supervisors: Ir. L. Colman, Dr. Ir. H. Eeckhaut
Counsellor: Ir. Ing. L. Lemiengre

Master's dissertation submitted in order to obtain the academic degree of
Master of Science in Electronics and ICT Engineering Technology

Academic year 2014–2015

Usage restrictions

The author gives permission to make this master dissertation available for consultation and to copy parts of this master dissertation for personal use. In the case of any other use, the copyright terms have to be respected, in particular with regard to the obligation to state expressly the source when quoting results from this master dissertation.

Preface

In the past year and a half I had the pleasure to work on the concept of integrating the software and hardware development worlds. In this thesis is contained the culminated knowledge and experience that was obtained during these many months, lest it be forgotten.

In the first part the tackled problem is explained along with a summarised background on many of the practices and concepts one needs know to fully understand the next part. In the second part the practical side of the work is demonstrated and thoughts are shared on the usability and future of this line of work.

Acknowledgements

In the course of learning, producing and revising both the code and the written text many helping hands guided my way. With this I would like to extend a thanks to them.

To my fellow students for the pleasant atmosphere that dominated most of my studies. For providing help when asked and receiving advice without reluctance. And for those many hours spent in the telecommunications lab working side by side on many things.

To my supervisors ir. Luc Colman and dr. ir. Hendrik Eeckhaut. The former for providing his many years of experience in supporting students, keeping a calm but firm grip on matters and always pushing to the next step. The latter for granting me the subject, providing his technical expertise and willingness to work on my problems whenever I asked.

Most certainly to my counsellor ir. ing. Lieven Lemiengre for providing an endless amount of feedback and brainstorming whenever. For providing technical expertise and insight when I had none to be found, for providing ideas and hooks to keep me going. For remaining realistic and setting achievable goals when the light at the end of the tunnel was darkest. And of course, for reviewing and critiquing this thesis.

To Jeroen Baeken and Sion Verschraege for being the friends that they are. For providing feedback on anything and support whenever it was needed.

Finally, to my darling fiancée Dorine Ndagsi for supporting me the many years we have been together. For providing a critical eye when needed and bringing me down a notch when explanations were overly complicated. And most certainly for being the driving force behind most of the work that got done at home, at work and in life.

To all those that are not named, you are not forgotten, the list would simply be endless.

Abstract

Contents

List of Acronyms	vii
I Problem and background	1
1 Problem	1
2 Introduction	2
2.1 Hardware Description Languages	2
3 Current industry practices	4
3.1 Assertions	4
3.2 Generic testbench	4
3.3 Coverage	4
3.4 Verification	5
3.5 Simulation tools	5
4 Software development practices	7
4.1 Test Driven Development	7
4.2 Continuous Integration	8
4.3 xUnit	9
4.4 Python	9
II Developing a framework	10
5 Outlining	10
5.1 First draft	10
5.2 Draft review	10
5.3 Fresh start	11
6 Using the framework	12
6.1 Preparing the testbench	12
6.2 Calling the parser	13
6.3 Report and log generation	14
6.4 Hudson-CI	15
6.5 Bitvis utility library	16
7 Results	17
8 Future work	18
9 Remarks	19
10 Conclusion	20
Appendices	23

Appendix A Code examples	23
A.1 DFF testbench	23
A.2 Revised DFF testbench	24
Appendix B Figures	25
B.1 Hudson-CI example statistics	25

List of Figures

1	Typical design flow, red indicates the main focus of this thesis.	3
2	Three step TDD design flow	8
3	Hudson-CI example statistics.	25

List of Acronyms

CC	Code Coverage	5
CI	Continuous Integration	8, 9, 15, 16
CRV	Constrained Random Verification	5
DFF	D Flip-Flop	2, 12
DT	Directed Testing	5
DUT	Device Under Test	3, 4
FC	Functional Coverage	5
FSM	Finite State Machine	5
HDL	Hardware Description Language	2, 4–6
IEEE	Institute of Electrical and Electronics Engineers	2
RC	Revision Control	8, 15, 16
RTL	Register Transfer Level	2
TDD	Test Driven Development	7
TFD	Test First Development	7
UUT	Unit Under Test	3, 5
VHDL	VHSIC Hardware Description Language	1–3, 5, 6, 10
XML	eXtensible Markup Language	9, 14

Part I

Problem and background

Tijdsuniformiteit in ganse document!

1 Problem

Revisie nodig: belangrijkste pagina

Developing digital hardware with the VHSIC Hardware Description Language (VHDL) is, like any code, prone to errors, either by the developer or by wrong product specifications. To ensure errors are weeded out before the more expensive roll-out or production begins, the code must be subjected to rigorous testing. *Currently, large and impractical tests are needed to fully test a product.*

productie != einddoel alle VHDL -> FPGAs en FPGA verdelingen

Because testing is such a time consuming process, finding errors often results in severe delays due to the need to both correct the error and test for others. Therefore it is in the best interests of both testing- and software engineers to write testbenches with maximal coverage, optimal readability and minimum time spent. It is also important to find and correct errors with minimal delay and maximal efficiency. This entire process should affect the least amount of code possible in order to minimize time spent retesting and modifying the code. *Betere samenvatting + meer gevolgen*

In this thesis, the objective is to explore the possibility of creating an operating system independent framework. This framework should allow users to quickly and consistently create, modify, execute and evaluate testbenches. To accomplish all of this, a number of industry standard tools will be incorporated around a central Python script. This combination should ensure timely and automated building, testing and test report generation.

2 Introduction

2.1 Hardware Description Languages

Meer bronvermelding

A Hardware Description Language (HDL) can be used to describe digital electronics, i.e. hardware, in different levels. The level that uses certain blocks of logic gates to describe more complex behaviour is called the Register Transfer Level (RTL). Some blocks are standard implementations that have been widely used and are nearly fully optimized, such as memories, flip-flops and clocks. VHDL is such a language, having been developed in the eighties of the twentieth century, originally to have a uniform description of hardware brought in by external vendors to the U.S. department of defence. It was quickly realized that simulation was possible with a good description and the language evolved to be used as such.[1, 2] The final step was to create tools that could not only simulate, but also synthesize (i.e. create actual hardware layouts) from these descriptions.[3, 4, 5],[6] An RTL flip-flop implementation written in VHDL is shown here:

```
LIBRARY IEEE;
USE IEEE.std_logic_1164.ALL;

ENTITY dff IS
    PORT(d      : IN  std_logic;
         clk     : IN  std_logic;
         q       : OUT std_logic;
    END dff;

ARCHITECTURE Behavioural OF dff IS
BEGIN
    PROCESS (clk)
    BEGIN
        IF rising_edge(clk) THEN
            q <= d;
        END IF;
    END PROCESS;
END Behavioural;
```

The Institute of Electrical and Electronics Engineers (IEEE) 1164 library provides a number of extensions on the original VHDL IEEE 1076 specification that allow a more realistic simulation and description of hardware behaviour.[7] An *entity* defines the inputs and outputs of a certain building block, in this case the D Flip-Flop (DFF). The *architecture*, in this case Behavioural, takes the description of an entity and assigns a real implementation to it. In this architecture, we have one process and it is *sequential*, meaning that every update in the process follows an update of the *clk*, the clock signal. The *d* stands for delay, and it simply puts on its output, *q*, that which was on the input, *d*, one clock period earlier. All *processes* are executed in parallel, this does not mean that all are triggered at the same time, nor do they take equally as long to finish, but it means that any process can be executed alongside any other process. In this case there is only one (nameless) process that describes the entire behaviour of the flip-flop. The process waits for the rising edge of the clock, which is a transition from zero to one, after which it schedules the value of *d* to be put on *q* when the next rising edge appears.

Hierarchisch testing: figuur, uitleg

Wat is een testbench bvb, hoe werkt dit? niet te veel stappen overslaan

This is a basic example of an entity, an architecture and a process. Before the code can be put to use in a working environment, it needs to be tested first. This is done through the use of *testbenches*.^[8] Testbenches are made up of code that takes a certain building block, the Unit Under Test (UUT) or Device Under Test (DUT). The testbench then puts a certain sequence of values on the inputs and monitors the outputs.^[9] Applying this to the example listed earlier, the testbench would contain a process with a clock, signals coupled with the ones in the entity, some stimuli and *wait* statements. The signals are linked to the DFF, which is now the UUT. Then the clock starts ticking and the input *d* is made '0' or '1' every now and then. All that is left is to assure the output *q* is always '0' and '1' exactly one clock cycle later. The full code is listed in appendix A.1.

If the device performs normally, the received output sequence should match an expected output sequence. In these testbenches it is good practice to observe how well a device performs if its inputs behave outside of the normal mode of operation. When all of these tests have finished and the output performs as expected, the device is ready to be put into production or further down the developmental process.^[10]

The higher level components, such as a registry, employ a number of the lower level ones to create more complex logic.^[6] The flip-flop could be used in certain numbers to build a *register*, a collection of ones and zeroes (henceforth referred to as *bits*) that is used to (temporarily) store these values. The register could then be used alongside combinational logic to build an even bigger entity. The idea here is that small building blocks can be combined to produce vast and complex circuits that are nearly impossible to describe in one go.^[11] Adding all these layers together also creates a lot of room for error, and having a multi-level design makes it challenging to pinpoint the exact level and location of any errors.

If a device is not tested properly and faults propagate throughout development, they can be very expensive to correct.^[12] Therefore a large portion of time is spent writing and executing tests. In figure 1 an overview of VHDL design flow is given up until synthesis.

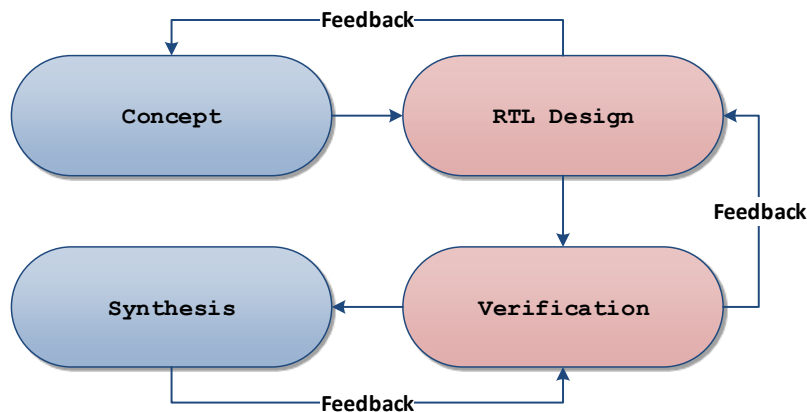


Figure 1: Typical design flow, red indicates the main focus of this thesis.

3 Current industry practices

As mentioned before, a number of practices exist to improve speed and quality of testing and coding. The bigger part of these practices are applied in the software development industry, where this is quite literally their entire business. Moving to HDLs, it stands to reason that code meant for synthesis may not be able to follow all of these best practices. However, the industry has formed several practices and *methodologies* to try and create a uniform verification process. The most well-known will be discussed in some detail below.

3.1 Assertions

Assertions are the standard practice of verification. An assert in VHDL is very simple: check whether some boolean condition is true. If true, do nothing, if false, return the error message and throw an error of a certain level, as in the following example:

```
assert (not Q) report "Unexpected output value" severity failure;
```

In this example, an error is thrown of the severity *failure*, which ends the simulation, if the value on the output *Q* (see section 2.1)) isn't *logically true*. This means the output has to have a value of *high* or *1*. The severity of the assertion can be in the range of notice to failure, and the simulator might be set to respond or stop only to a certain level of severity. Doing this for the right values at intervals gives the developer a quick overview of whether everything went according to plan. After all, if things went wrong, the assertion should have thrown an error here or there.

3.2 Generic testbench

The generic testbench operates as mentioned in section 2.1. It assigns every input and output on the DUT their counterpart in the testbench and contains a number of processes with stimuli. Standard procedure is:

1. Wait for some clock periods to 'ready' the design
2. Apply stimuli to the inputs
3. Wait for the appropriate number of clock cycles
4. Use asserts to check whether the outputs have the right values
5. Repeat steps 2 through 4 until satisfied
6. End with an infinite 'wait' to suspend the process

Creating this kind of testbench for a large, hierarchical project would certainly become lengthy and unclear. To counter these disadvantages, a number of practices were created to keep control over what and how designs are tested. The more used of these practices are explained below.

3.3 Coverage

Coverage is a generic term that is used to describe how fully a design has been tested on one aspect or another. There exist many tools for different coverage analyses, but in this section we will focus only on the types of coverage.

3.3.1 Code Coverage

In development, Code Coverage (CC) is a type of measurement to indicate how well the source code has been tested. With the use of a coverage report, unused blocks of code can be uncovered, these blocks might indicate unnecessary code or a bug. Imagine a Finite State Machine (FSM) with an unused reset state, this might indicate that the reset isn't functioning properly or there are no tests covering the reset. CC does not, however, provide any real functional analysis. It does not indicate any missing lines of code nor does it tell you whether the inputs and outputs behave properly.

3.3.2 Functional Coverage

Controleren

Functional Coverage (FC) is the practice of measuring whether the UUT meets with certain specifications at specific times during the testing process. These specifications are created by the developer and are used to check whether the design performs as expected. Good practice is to include corner cases, cases that cover very rare occurrences and so on. That way, the device is sure to be in working condition even under unexpected circumstances.

3.4 Verification

3.4.1 Constrained Random Verification

Revision! Voorbeelden, niet noodzakelijk VHDL, bronvermelding (algemeen)

Resultaat en hoe controleren bij random input

Constrained Random Verification (CRV) is an industry practice where one or more inputs are generated randomly, within certain bounds or *constraints*. This practice was brought into use after designs grew too large for Directed Testing (DT) to support. DT has verification engineers write out very specific things they want to test, for instance, a reset pulse to verify the reset working correctly. CRV opposes this with the idea that for all behaviour to be tested properly in large designs, the amount of time spent writing and executing tests would simply become too great. It proposes a solution where inputs are generated randomly, within certain bounds, but in a sufficiently large quantity to have implicitly covered all scenarios. It is important to note that in DT, expected behaviour is directly tested, but in CRV it is likely to be the unexpected behaviour that gets tested too. This solved the long standing problem of testing any behaviour, including the unexpected.

3.4.2 Formal Verification

On top of the aforementioned, there are several more practices that have unique ways of verifying the properties of a design, but aren't used sufficiently to merit full detailing. Formal verification is such a practice, where the core idea is to mathematically prove the design from its specifications. The upside is that the design is completely verified, however, it is out of use because proving large designs is not only tedious but takes up large amounts of man-hours.

3.5 Simulation tools

As mentioned in section 2, HDLs are used for developing hardware, and need to be tested and build as such. Like any other programming language, they need a dedicated compiler to fault-check the code and build the binaries. Unlike other programming languages they need a simulator in order to verify the builds. There exist many compilers and simulators, almost none are exclusive for VHDL, almost all are dual-language and support some form of Verilog, a different HDL. However, many

of them refuse to support the latest additions to the VHDL language specification, even the 2002 additions are hard to be found.[13, 14, 15, 16]

3.5.1 ModelSim

ModelSim is the simulator that was investigated for several reasons. First, a free student edition was available. Considering licenses outside of school can easily cost upward of \$25,000 (€20,250 at time of writing) this made it ideal for any thesis or student related work. Proof of this is the extensive use of ModelSim in the courses related to HDL development. Second, ModelSim supports all versions of VHDL, which is the HDL we are processing. Even in 2014, only one other tool was found to support all of VHDL-2008, which is Aldec's *Active-HDL*. And last but not least, ModelSim is one of the industry's most used simulators, enabling a pool of experience to be consulted.[17]

Figuurkje of vergelijking tussen simulators?

4 Software development practices

During the making of this thesis, a number of approaches were investigated and some were put to practical use. In this chapter, the more useful and tried of the aforementioned are discussed in detail.

4.1 Test Driven Development

Test Driven Development (TDD) is a proven development technique that has regained traction in the past decade, primarily through the efforts of Kent Beck.[18] This practice has proven to increase test coverage, decrease defect density [19] as well as improve code quality.[20, 19, 21] The technique focuses on tests being created before the actual code. It is important to make certain distinctions before going more in depth on the used methods. The developing community has a great many practices, each with their own names and methods, and hardly none are mutually exclusive.

4.1.1 Unit Testing

To understand TDD, a basic knowledge of *Unit Testing* is required. In software testing, a unit test is a test designed to check a single unit of code. Ideally, this unit is the smallest piece in which the code can be divided. A unit test should always test only a single entity, and only one aspect of that entity's behaviour. This division in units has a number of benefits, one of the most important being that code is exceedingly easy to maintain. Furthermore, the division of the code makes changes, when needed, fast to be carried out and ensures that only the modified code needs to be re-tested.

4.1.2 Test First Development

Herschrijven Another main component of TDD is Test First Development (TFD), a technique that has a developer writing tests first, before any code has been written. This method makes the developer think on what the code has to achieve, rather than what the specific implementation has to be. A key feature of a new test is that it has to fail during its first run. If not, the test is obsolete seeing as the functionality it tests has already been implemented. After being run for the first time (and failing), the developer implements just enough code to get the test to pass. Once the test succeeds, it is time for a new test.

4.1.3 Refactoring

The third pillar of TDD is refactoring. After the tests succeed, it is necessary to clean up the code. A well-done TFD implementation uses the bare amount of code needed to make the test pass, but this is of course usually not the best code possible. Refactoring means that you take existing code and modify only the code itself to perform better. This leaves both the input and output of the tests and code unchanged, only the way the code processes input is altered. It is important in this step to edit nothing in the test code or the outputs or inputs. Otherwise, either the test would behave differently or new tests would have to be written. The latter goes directly against the TFD principle.

4.1.4 Test Driven Development

Test Driven Development is a combination of the previously mentioned techniques. A Unit Test is written before any code is, the test is then executed and should fail. After the failure, the most basic code to make the test pass is implemented. The test is then executed again and should pass.

After this first pass, the code written for the passing of the test, and only this code, is edited to perform and look better. This follows all steps mentioned above, a *Unit Test* is written according to *Test First Development* and is *Refactored* later.

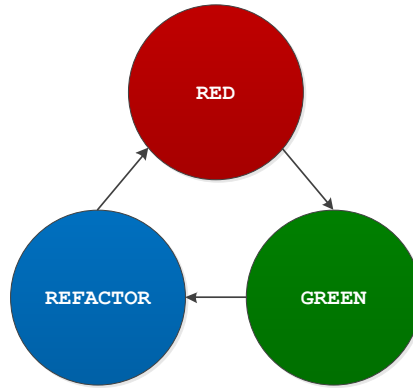


Figure 2: Three step TDD design flow

4.2 Continuous Integration

Continuous Integration (CI) is a software development technique in which developers upload the edits on the software, or their *build*, to a central server which then *continuously integrates* the code from multiple developers. This to prevent integration headaches when the code of multiple developers has diverged to such an extent that it would take much more time to make the edits work together than if they had been integrated early on.

Combining all of these practices saves developers, and by extension the company they might work for, a lot of time and of money. Considering today's competitive market for software development, any edge that can be obtained is a plus. Even more so when plenty of free Continuous Integration solutions exist that employ open or widely used standards.

4.2.1 Revision Control

There are many aspects to a properly maintained CI system, but one key aspect of overall programming has to be Revision Control (RC). Not to be confused with the "undo" button in your preferred editor, a good RC system does allow for any and all mistakes made over different edits to be undone with very little work. There exist many systems for revision control, but they all have in common that they track changes one way or the other, and most importantly that these changes can be undone.

4.2.2 Build Automation

A useful but not required aspect is build automation. Using a timer or trigger, the build automatically runs with the latest updates, preferably from an RC system. This way, the binaries are always up to date and the developer does not need to wait for compilation to run the latest tests. Although the latter is less imported in a proper CI system as will be discussed further on.

4.2.3 Test Automation

As the code is built at scheduled times, and testing is needed regardless, it makes perfect sense to add a testing step to the automated build. Automating tests saves the developers yet another part of their time, thus freeing more for the actual development and debugging steps. A good CI system can read test reports, or at least some standard of reports.

4.3 xUnit

xUnit is a collection of frameworks that all follow the same basic principle. The xUnit specification defines several key components for a testing framework. They encompass an implementation of a *testcase* which contains a single unit test. These testcases are then enveloped in *testsuites*, which are groups of tests that need the same conditions before they can be executed. There are more implementation details but these are not relevant to this thesis. JUnit is an implementation for the Java programming language of the xUnit specification. A useful part of the specification is a standard format for the test reports. The reports are written in eXtensible Markup Language (XML), which is a type of language used for formatting data. The JUnit format is supported by numerous (open source) tools, which makes it an ideal candidate for further investigation.[22, 23]

4.4 Python

Python is a high-level computer programming language that first appeared in 1991, with the third major revision being released in 2008. It supports object-oriented and structured programming and is easy to use as a scripting language. A great feat of Python's community is that there are many (open source) libraries available for just about any function that comes to mind. This on top of the already impressive amount of libraries that Python itself supports. In addition to this, Python has all of its standard features explained in great detail with good examples in its online documenting system. The combination of these features allows any programmer, even with very little know-how, to quickly put together anything that comes to mind.

Part II

Developing a framework

In part I different aspects from both the software and VHDL development worlds were discussed in varying levels of detail. In this part bits and pieces of each subject are combined to form a new whole, a VHDL development framework.

5 Outlining

Before work begins on developing the framework, there need to be some boundaries set and goals to work towards. As VHDL development is done on both Windows and Linux, it only makes sense to keep the whole framework as platform independent as possible. To add to this, the framework needs to be developed in the short span of under a year by one developer who has had little experience doing so. The language chosen thus must be easy to master and work on all platforms with as few as possible modifications.

5.1 First draft

In section 3 some current industry practices were discussed and one of the very basic VHDL testing methods was found to be assertions. In order to remain as broad as possible, work started with processing these assertions first. As mentioned in section 4.1, unit testing is a method that tests an as small as can be part of a code's behaviour. Applied to VHDL, a unit test would then be the part of the code that the assertion checks. This under the assumption that the assertion checks for simple boolean truths such as *output q equals '1'* and not a complex mix of logic.

To the likeness of unit testing, these parts of code were separated into their own testbenches. Methods of separation were not available, and thus one was developed. For complete accuracy, a lexical analyzer for VHDL would have been needed, but the development of such is worth its own thesis and such a more simple method was used. Instead, estimation of the level of depth in the testbench structure was made using VHDL keywords such as *process* and *begin*.

Furthermore, because lexical analysis was out of the question, the constructs that each assert relied on were unable to be identified. A solution was found in the form of procedures and functions. These were placed in the architecture header, and with these single-line unit test could be called from the architecture body. All that was left for the parser to do was to find the location of these lines and place each of them in a newly created testbench.

5.2 Draft review

Even though it sounds simple, this method was still needlessly complicated and a better method had to be devised. Even then, the parser created a heap of little, separate testbenches which added more work for the developer as he had to execute all of these separately. A possible solution could be the automatic execution and result capture of the created testbenches, reducing the amount of work to a lightly modified testbench and a single execution of the parser.

5.3 Fresh start

As everything up until now was based on code created on the fly, it became clear that the original files weren't ready to be refactored or otherwise modified. The experience gained from writing everything mentioned in section 5 was put to good use, and a clean build was started. With this build a number of assumptions were made:

- Optional arguments to modify the behaviour should be specified
- Full on automation should be included
- A log detailing events should be held
- Proper documentation should be provided

All of these modifications made the framework suitable for developers. The optional arguments allowed for a greater control over the program. The automation countered the extra work created from the generation of all the separate testbenches. The log made it easier to figure out where things went wrong should they go wrong. And lastly, the documentation was a given for any decent project.

6 Using the framework

To properly use the framework, a number of things had to be considered. Firstly, not all testbenches were suited to be processed by the parser; it relied heavily on the independence of tests from one another. Therefore, tests that relied on outputs from previous tests needed to be kept together, which lead to a large portion of such testbenches needing to be completely rewritten.

Secondly, even with properly suited testbenches, the output needed to remain uniform and recognizable. As mentioned in section 5.1, to have done this automatically would have required a full blown lexical analysis which was simply too complex. As a solution, the use of a testing library was proposed which would provide uniform tests and output.

6.1 Preparing the testbench

For the testbench to be properly parsed, it needed some preparation first. The blocks of tests, henceforth referred to as testsuites, were to be independent and separated by keywords that signify the beginning and end of a testsuite. Not only this, but the standard asserts were to be replaced with functions from the library, and the library of course needed to be included. An example using the DFF from section 2.1 (full code in appendix A.1):

```
...
    assert q = '0'
        report "Wrong output value at startup" severity FAILURE;
    d <= '1';
    WAIT FOR clk_period;
    assert q = '1'
        report "Wrong output value at first test" severity FAILURE;
...
```

Would turn into (See appendix A.2):

```
...
--Test 1
check_value(q = '0', FAILURE, "Wrong output value at startup");
write(d, '1', "DFF");
check_value(q = '1', FAILURE, "Wrong output value at first test");
...
--End 1
...
```

In the full code it is shown that the functions are overloads of existing functions in the *BitVis* library, which will be discussed in section 6.5. Also visible here are the keywords *--Test* and *--End* with which the testsuites are separated. The number next to it is a testsuite identifier, but is not necessary as the parser keeps track of the count.

Overloading functions, including libraries and seemingly completely overhauling the testbench may seem like a lot of work for a small testbench such as this. While true, this method is easily scalable for testbenches of much larger sizes and with designs of greater complexity. If the developer created a testbench starting with this approach, no time was wasted redoing any code and the readability was greatly improved. Lastly, automated logging was built in these procedures to keep track of progress during testruns. This allowed for easier and uniform report generation (see also section 6.3).

6.2 Calling the parser

The parser was created as a script, written in Python, thus it was necessary to have access to a command-line interface as python requires one to run its scripts. Originally, the call was as easy as `python testbench_parser.py tb_dff.vhd`. There was one testbench to be parsed and everything happened automatically in default methods, hardcoded in the script. During further development it became clear that there were many ways a developer might want to test their project. As such there was a need for a way to the parser to be modified in the way it ran. Possible solutions included different scripts, a settings file but ultimately the decided upon method was the use of arguments.

6.2.1 Arguments to the parser

Python had a built-in argument parser, the library *argparse*. With this it became possible to have a complex yet simple to use command-line interface with both optional and required arguments. Included in the parser was the option for a clear and thorough help, providing users with all the information they needed to run the script. A simple example is listed below:

```
$ python src\testbench_parser.py -m partitioned -l Project\sim\tb_dff_r.vhd -c
```

Using this command, the testbench from appendix A.2 is processed using the *partitioned* method, which is the method that uses the keywords *Test* and *End*. The *-c* flag ensures that output of the simulator (in this case ModelSim) is displayed and not just captured and stored as is default. Below are all the flags and their help text:

- *'-c', '--cmd'* specifies output to be displayed on the command line
- *'-d', '--dest'* specifies a custom path for the log
- *'-f', '--file'* specifies *-l/--list* is a file with a list of .vhd files
- *'-l', '--list'* specifies the list of .vhd files to be processed (at least one)
- *'-m', '--method'* specifies what method was used to write the testbench
- *'-p', '--precompiled'* specifies location of the precompiled dependencies, requires full path
- *'-r', '--runops'* specifies custom arguments for simulation start
- *'-v', '--version'* specifies a different VHDL version, default is 2008

With this parser, it also became possible to run multiple testbenches with one call to the script. This allowed to test multiple levels of a hierarchic design, or even completely different designs in one execution. Most of the flags are self-evident, but those that are not are explained below.

The *-p* or *--precompiled* flag points to a text file that contains instructions very similar to those found in a unix *Makefile*. They are commands that need to be executed before the testbench can be compiled. This would be all of the source files used, in their specific order and any special libraries that need to be created beforehand. A full editor might have recognized the dependencies and libraries on its own and created a Makefile accordingly but here the lack of a decent lexical analysis prevented this.

The *-r* or *--runops* flag is to specify a custom command for ModelSim to execute during the execution of the newly made testbenches. The default value is *-do "run -all;exit"*, which simply starts the simulation until its end and then exits. However, developers might want to load different memory files in a memory or specify a custom .do file with more elaborate commands.

6.2.2 Processing methods

In section 6.2.1 the processing method *partitioned* was mentioned as well as the *-m* or *--method* flag. The parser thus supports multiple methods of dividing the testbench, they are listed below:

- Start Stop with identifiers
- Line per line
- Partitioned with identifiers

In the Start Stop method, every single line between certain keywords is assumed to contain a test. It is assumed that everything above the keywords is architecture header and everything below is a general 'end of the architecture body'. This method is the easiest to parse, look for *--Start* and create a new testbench with every line until *--Stop*.

In the Line method, the parser looks for a process. This process should contain one test per line. It looks for this process itself and as such, can easier make a mistake than the Start Stop method.

Finally, in the Partitioned method, the developer indicates which blocks are testsuites by using the *--Test* and *--End* keywords. Everything in between these keywords is assumed to be a single block of testcases, to be put in the same new testbench. As such, and unlike the previous two methods, it is possible to define multiple testsuites.

6.3 Report and log generation

After the parser from section 6.2 had run its course, results were captured automatically. However, making sense of a whole lot of command line output from a text file was challenging. ModelSim made this more difficult by adding a header and a lot of information that isn't really interesting at this time of development. Things such as which files were loaded prior to the execution and which preference file was being read were not needed for a quick overview. However, they might still be needed in the event of severe failure.

6.3.1 Basic report

A great deal of filtering of the output file was required, only the passed and failed testresults were needed for a proper report. In section 6.5, it will be shown that whether the test passed or failed is done with simple keywords. A simple filtering on these words per line of the output file returned every testresult, neatly ordered in passed and failed groups. A total testcount was tallied from the combination, and as such a crude report was written to a text file.

6.3.2 XML report

Previously discussed in section 4.3, the JUnit implementation of xUnit uses XML for report viewing. The editor that was used throughout the development of the thesis is *Eclipse*, which was written in Java, the same language JUnit is an implementation for. They could be read and displayed in Eclipse by manually navigating to them or editing the project properties to automatically read them.

To create the XML reports, a pre-made, open-source Python implementation of a JUnit report, aptly named *python-junit-xml* was used. This package required its own external component to be

installed, called `setuptools`.^[23, 24] In this thesis, versions 1.0 and 3.5.1 respectively were used, but versions 1.3 and 8.0.4 are available at time of writing.

6.3.3 Logkeeping

Finally, a log was kept detailing events throughout the parser's execution. It contained critical events along with timestamps for precise debugging. Everything within this log file was related to only the parser and its workings. The file that contained details about ModelSims execution was not saved.

6.4 Hudson-CI

For full automation, a CI system was integrated into the framework. The CI solution that was incorporated was Hudson-CI which provided an extensive range of features including:

- Timed and triggered building from an RC repository
- Automated testing of builds
- Reading reports in the *JUnit* format
- Graphical and statistical overview of test progress throughout builds

Hudson is available as both a running `.war` file (a Java web application that runs on a local machine) and as an installed service.^[25] The version used throughout this thesis is 3.2.0 but at time of writing 3.2.1 is available.

6.4.1 Using Hudson-CI

For ease of use, Hudson was installed as a local service. By default the gateway is accessed at port 8080 of the local machine, usually by typing `localhost:8080` in a browser. The following steps were followed to successfully complete several testruns on a Windows 8 machine:

1. Create a new job with:
 - (a) Git repository as SCM
 - (b) The batch command listed in section 6.2.1.
 - (c) JUnit test results published under `VHDL_TDD_Parser/*/*.xml`
 - (d) Manual build activation to prevent overload
2. Press the *Build now* button

This automatically downloaded the source, compiled the external testbench for the DFF, executed the different architectures, captured and formatted the output and published the XML report. For successive runs only step 2 has to be repeated, the code is automatically updated from git should it change. An example of captured statistics is shown in appendix B.1.

6.5 Bitvis utility library

Throughout the development of the framework multiple approaches were used to enhance developer experience including a library with widely used and usable functions. At first this was self developed, however, after a short while the existing *Bitvis utility library* was used. It was developed by the Norse company Bitvis for verification with all versions of VHDL. [26] The library promoted overloading its functions with implementations for the project that was being developed. It also provided with these functions an easy to use logging function with great customizability, which made it ideal for use in the framework.

To make use of the library, all that needed to be done was to include it in the project and use or overload its functions where needed. However, using the *check* or *check_value* function was critical seeing as the test parser relied on the output created by this function to assess test success. An example is listed below (full code in appendix A.2):

```
...
LIBRARY bitvis_util;
USE bitvis_util.types_pkg.ALL;
USE bitvis_util.string_methods_pkg.ALL;
USE bitvis_util.adaptations_pkg.ALL;
USE bitvis_util.methods_pkg.ALL;
...
PROCEDURE log(
    msg    : STRING) IS
BEGIN
    log(ID_SEQUENCER, msg, C_SCOPE);
END;

PROCEDURE write(
    SIGNAL data_target : IN STD_LOGIC_VECTOR;
    CONSTANT data_value : IN STD_LOGIC_VECTOR;
    CONSTANT msg        : IN STRING) IS
BEGIN
    data_target <= data_value;
    WAIT FOR clk_period;
    log(msg & " write(Target:" & to_string(data_value, HEX, AS_IS, INCL_RADIX)
        & ", " & to_string(data_target, HEX, AS_IS, INCL_RADIX) & ")");
END;
...
    write(d, '1', "DFF");
    check_value(q = '1', FAILURE, "Wrong output value at first test");
...
```

7 Results

8 Future work

9 Remarks

Iets over VHDL features, verbeteringen etc

10 Conclusion

References

- [1] Roger Lipsett, Erich Marschner and Moe Shahdad. “VHDL - The Language”. In: *IEEE Design & Test of Computers* 3.2 (Apr. 1986), pp. 28–41. DOI: 10.1109/mdt.1986.294900.
- [2] J.H. Aylor, R. Waxman and C. Scarratt. “VHDL - Feature Description And Analysis”. In: *IEEE Design & Test of Computers* 3.2 (Apr. 1986), pp. 17–27. DOI: 10.1109/mdt.1986.294899.
- [3] R.D. Acosta, S.P. Smith and J. Larson. “Mixed-mode simulation of compiled VHDL programs”. In: *1989 IEEE International Conference on Computer-Aided Design. Digest of Technical Papers*. IEEE Comput. Soc. Press, 1989. DOI: 10.1109/iccad.1989.76930.
- [4] T.E. Dillinger et al. “A logic synthesis system for VHDL design descriptions”. In: *1989 IEEE International Conference on Computer-Aided Design. Digest of Technical Papers*. IEEE Comput. Soc. Press, 1989. DOI: 10.1109/iccad.1989.76906.
- [5] R. Camposano, L.F. Saunders and R.M. Tabet. “VHDL as input for high-level synthesis”. In: *IEEE Design & Test of Computers* 8.1 (Mar. 1991), pp. 43–49. DOI: 10.1109/54.75662.
- [6] R. Waxman, L. Saunders and H. Carter. “VHDL links design, test, and maintenance”. In: *IEEE Spectr.* 26.5 (May 1989), pp. 40–44. DOI: 10.1109/6.30762.
- [7] *1164-1993 - IEEE Standard Multivalued Logic System for VHDL Model Interoperability*. 1993. DOI: 10.1109/ieeestd.1993.115571.
- [8] Janick Bergeron. *Writing Testbenches: Functional Verification of HDL Models*. Springer US, 2000.
- [9] D. Biederman. “An overview on writing a VHDL testbench”. In: *Proceedings The Twenty-Ninth Southeastern Symposium on System Theory*. IEEE Comput. Soc. Press, 1997. DOI: 10.1109/ssst.1997.581677.
- [10] F. Wotawa. “Debugging {VHDL} designs using model-based reasoning”. In: *Artificial Intelligence in Engineering* 14.4 (2000), pp. 331–351. ISSN: 0954-1810. DOI: 10.1016/S0954-1810(00)00021-2.
- [11] P. Kission, Hong Ding and A.A. Jerraya. “VHDL based design methodology for hierarchy and component re-use”. In: *Proceedings of EURO-DAC. European Design Automation Conference*. IEEE Comput. Soc. Press, 1995. DOI: 10.1109/eurdac.1995.527446.
- [12] Charles M. Weber, Neil C. Berglund and Patricia Gabella. “Mask Cost and Profitability in Photomask Manufacturing: An Empirical Analysis”. In: *IEEE Transactions on Semiconductor Manufacturing* 19.4 (2006), pp. 465–474.
- [13] Aldec Inc. *Active-HDL Configurations*. 2014. URL: https://www.aldec.com/en/products/fpga_simulation/active-hdl (visited on 19/12/2014).
- [14] Cadence. *Incisive Enterprise Simulator*. 2014. URL: http://www.cadence.com/products/fv/enterprise_simulator/pages/default.aspx (visited on 19/12/2014).
- [15] Xilinx. *Vivado Synthesis*. 2014. URL: <http://www.xilinx.com/support/answers/62005.html> (visited on 19/12/2014).
- [16] Altera. *Quartus II support for VHDL 2008*. 2014. URL: http://quartushelp.altera.com/14.1/master.htm#mergedProjects/hdl/vhdl/vhdl_list_2008_vhdl_support.htm?GSA_pos=1&WT.oss_r=1&WT.oss=vhdl%202008 (visited on 19/12/2014).

- [17] Altera. *ModelSim 10.0 release notes*. 2014. URL: http://www.altera.com/download/os-support/release-notes_10.0c.txt (visited on 19/12/2014).
- [18] Martin Fowler. *UnitTest*. 2014. URL: <http://martinfowler.com/bliki/UnitTest.html> (visited on 30/06/2014).
- [19] L. Williams, J.C. Sanchez and E.M. Maximilien. “On the Sustained Use of a Test-Driven Development Practice at IBM”. In: *AGILE 2007 Conference (AGILE 2007)*, 13-17 August 2007, Washington, DC, USA. AGILE '07. IEEE Computer Society, 2007, pp. 6–14. ISBN: 0-7695-2872-4. DOI: 10.1109/AGILE.2007.43.
- [20] M. Siniaalto and P. Abrahamsson. “A Comparative Case Study on the Impact of Test-Driven Development on Program Design and Test Coverage”. In: *Proceedings of the First International Symposium on Empirical Software Engineering and Measurement*. ESEM '07. IEEE Computer Society, 2007, pp. 275–284. ISBN: 0-7695-2886-4. DOI: 10.1109/ESEM.2007.2.
- [21] B. Thirumalesh and N. Nachiappan. “Evaluating the efficacy of test-driven development: industrial case studies”. In: *ISESE*. ACM, 2006, pp. 356–363. ISBN: 1-59593-218-6. DOI: 10.1145/1159733.1159787. (Visited on 23/01/2007).
- [22] J. Kivi et al. “Extreme programming: a university team design experience”. In: *Canadian Conference on Electrical and Computer Engineering*. CCECE '00. IEEE, 2000, pp. 816–820. ISBN: 0-7803-5957-7. DOI: 10.1109/CCECE.2000.849579.
- [23] Brian Beyer. *Python JUnit XML*. 2014. URL: <https://pypi.python.org/pypi/junit-xml/1.3> (visited on 07/05/2014).
- [24] Jason R. Coombs and Phillip J. Eby. *setuptools*. 2014. URL: <https://pypi.python.org/pypi/setuptools> (visited on 07/05/2014).
- [25] *Hudson-CI*. 2014. URL: <http://hudson-ci.org/> (visited on 25/05/2014).
- [26] *Bitvis Utility Library*. 2014. URL: <http://bitvis.no/products/bitvis-utility-library/> (visited on 25/08/2014).

Appendices

A Code examples

A.1 DFF testbench

```
LIBRARY IEEE;
USE IEEE.std_logic_1164.ALL;

ENTITY tb_dff_r IS
END tb_dff_r;

ARCHITECTURE Behavioural OF tb_dff_r IS
    COMPONENT dff
    PORT(
        d    : IN  STD_LOGIC;
        clk  : IN  STD_LOGIC;
        q    : OUT STD_LOGIC;
    END COMPONENT;

    SIGNAL d    : STD_LOGIC := '0';
    SIGNAL clk  : STD_LOGIC := '0';
    SIGNAL q    : STD_LOGIC := '0';

    CONSTANT clk_period : TIME := 10 ns;

BEGIN
    uut: dff PORT MAP (
        d => d,
        clk => clk,
        q => q
    );
    clk_process : PROCESS
    BEGIN
        clk <= '0';
        WAIT FOR clk_period/2;
        clk <= '1';
        WAIT FOR clk_period - clk_period/2;
    END PROCESS;

    stim_proc: PROCESS
    BEGIN
        WAIT FOR clk_period;
        ASSERT q = '0'
            REPORT "Wrong output value at startup" SEVERITY FAILURE;
        d <= '1';
        WAIT FOR clk_period;
        ASSERT q = '1'
            REPORT "Wrong output value at first test" SEVERITY FAILURE;
        d <= '0';
        WAIT FOR clk_period;
        ASSERT q = '0'
            REPORT "Wrong output value at final test" SEVERITY FAILURE;
        WAIT;
    END PROCESS;
END Behavioural;
```


A.2 Revised DFF testbench

```
LIBRARY IEEE;
USE IEEE.std_logic_1164.ALL;

LIBRARY bitvis_util;
USE bitvis_util.types_pkg.ALL;
USE bitvis_util.string_methods_pkg.ALL;
USE bitvis_util.adaptations_pkg.ALL;
USE bitvis_util.methods_pkg.ALL;

ENTITY tb_dff IS
END tb_dff;

ARCHITECTURE Behavioural OF tb_dff IS
    COMPONENT dff
    PORT(
        d    : IN  STD_LOGIC;
        clk  : IN  STD_LOGIC;
        q    : OUT STD_LOGIC;
    END COMPONENT;

    SIGNAL d    : STD_LOGIC := '0';
    SIGNAL clk  : STD_LOGIC := '0';
    SIGNAL q    : STD_LOGIC := '0';
    CONSTANT clk_period : TIME := 10 ns;

    PROCEDURE log(
        msg    : STRING) IS
    BEGIN
        log(ID_SEQUENCER, msg, C_SCOPE);
    END;

    PROCEDURE write(
        SIGNAL data_target : IN STD_LOGIC_VECTOR;
        CONSTANT data_value : IN STD_LOGIC_VECTOR;
        CONSTANT msg : IN STRING) IS
    BEGIN
        data_target <= data_value;
        WAIT FOR clk_period;
        log(msg & " write(Target: " & to_string(data_value, HEX, AS_IS, INCL_RADIX)
            & ", " & to_string(data_target, HEX, AS_IS, INCL_RADIX) & ")");
    END;

BEGIN
    uut: dff PORT MAP (
        d => d,
        clk => clk,
        q => q
    );
    clk_process : PROCESS
    BEGIN
        clk <= '0';
        WAIT FOR clk_period/2;
        clk <= '1';
        WAIT FOR clk_period - clk_period/2;
    END PROCESS;

    stim_proc: PROCESS
    BEGIN
        check_value(q = '0', FAILURE, "Wrong output value at startup");
        write(d, '1', "DFF");
        check_value(q = '1', FAILURE, "Wrong output value at first test");
        write(d, '0', "DFF");
        check_value(q = '0', FAILURE, "Wrong output value at final test");
    END PROCESS;

END Behavioural;
```

B Figures

B.1 Hudson-CI example statistics

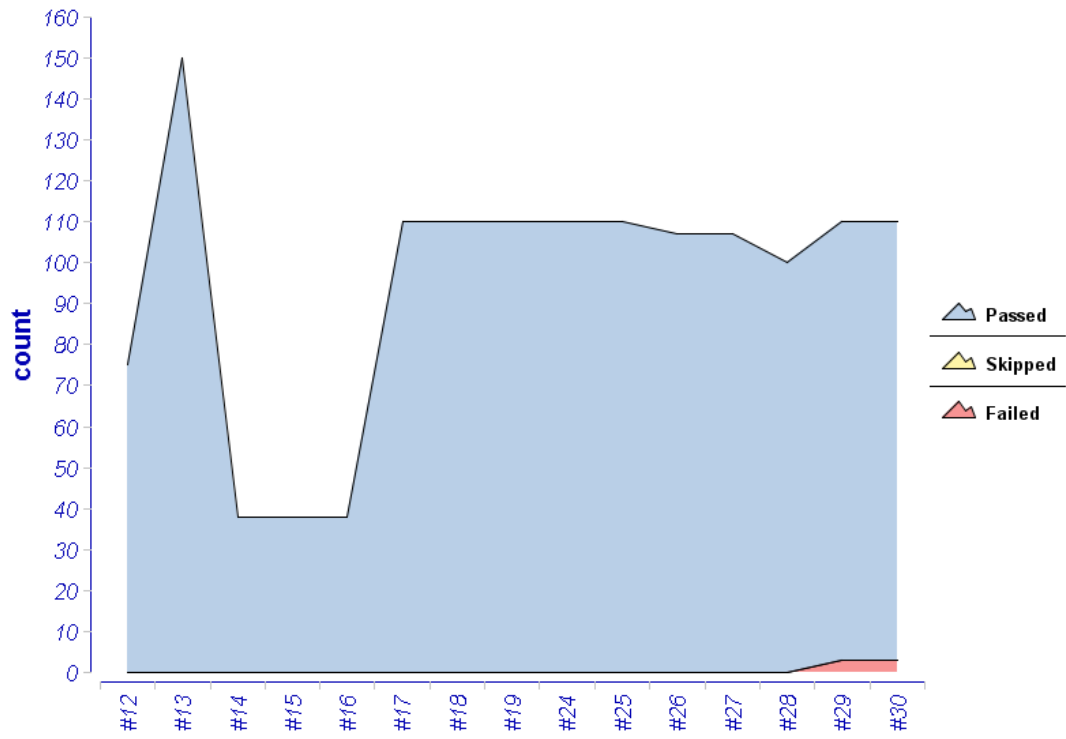


Figure 3: Hudson-CI example statistics.

